2.5V/3.3V Differential 1:4 Clock/Data Fanout Buffer/ Translator with CML Outputs and Internal Termination

Description

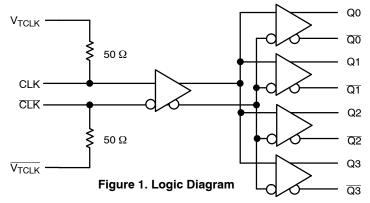
The NB7L14M is a differential 1-to-4 clock/data distribution chip with internal source terminated CML output structures, optimized for minimal skew and jitter. Device produces four identical output copies of clock or data operating up to 8 GHz or 12 Gb/s, respectively. As such, NB7L14M is ideal for SONET, GigE, Fiber Channel, Backplane and other clock/data distribution applications.

Inputs incorporate internal 50 Ω termination resistors and accept LVPECL, CML, LVCMOS, LVTTL, or LVDS (See Table 6). Differential 16 mA CML outputs provide matching internal 50 Ω terminations, and 400 mV output swings when externally terminated with 50 Ω to V_{CC} (See Figure 14).

The device is offered in a low profile 3x3 mm 16-pin QFN package. Application notes, models, and support documentation are available at www.onsemi.com.

Features

- Maximum Input Clock Frequency up to 8 GHz Typical
- Maximum Input Data Rate up to 12 Gb/s Typical
- < 0.5 ps of RMS Clock Jitter
- < 10 ps of Data Dependent Jitter
- 30 ps Typical Rise and Fall Times
- 110 ps Typical Propagation Delay
- 6 ps Typical Within Device Skew
- Operating Range: $V_{CC} = 2.375 \text{ V}$ to 3.465 V with $V_{EE} = 0 \text{ V}$
- CML Output Level (400 mV Peak-to-Peak Output) Differential Output Only
- 50 Ω Internal Input and Output Termination Resistors
- Functionally Compatible with Existing 2.5 V/3.3 V LVEL, LVEP, EP and SG Devices
- These are Pb-Free Devices





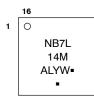
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MARKING DIAGRAM*



QFN-16 MN SUFFIX CASE 485G



A = Assembly Location

L = Wafer Lot Y = Year W = Work Week ■ Pb-Free Package

(Note: Microdot may be in either location)

*For additional marking information, refer to Application Note AND8002/D.

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 10 of this data sheet.

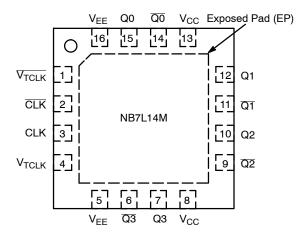


Figure 2. QFN-16 Pinout (Top View)

Table 1. PIN DESCRIPTION

| Pin | Name | I/O | Description |
|------|-----------------------|--|---|
| 1 | $\overline{V_{TCLK}}$ | _ | Internal 50 Ω Termination Pin for $\overline{\text{CLK}}$. |
| 2 | CLK | LVPECL, CML, LVCMOS, LVTTL, LVDS | Inverted Differential Clock/Data Input. (Note 1) |
| 3 | CLK | LVPECL, CML, LVCMOS, LVTTL, LVDS | Non-inverted Differential Clock/Data Input. (Note 1) |
| 4 | V _{TCLK} | - | Internal 50 Ω Termination Pin for CLK. |
| 5,16 | V _{EE} | Power Supply | Negative Supply Voltage. All V_{EE} pins must be externally connected to a Power Supply to guarantee proper operation. |
| 6 | Q3 | CML Output | Inverted Differential Output 3 with Internal 50 Ω Source Termination Resistor. (Note 2) |
| 7 | Q3 | CML Output | Non-inverted Differential Output 3 with Internal 50 Ω Source Termination Resistor. (Note 2) |
| 8,13 | V _{CC} | Power Supply | Positive Supply Voltage. All $V_{\rm CC}$ pins must be externally connected to a Power Supply to guarantee proper operation. |
| 9 | Q2 | CML Output | Inverted Differential Output 2 with Internal 50 Ω Source Termination Resistor. (Note 2) |
| 10 | Q2 | CML Output | Non-inverted Differential Output 2 with Internal 50 Ω Source Termination Resistor. (Note 2) |
| 11 | Q1 | CML Output | Inverted Differential Output 1 with Internal 50 Ω Source Termination Resistor. (Note 2) |
| 12 | Q1 | CML Output | Non-inverted Differential Output 1 with Internal 50 Ω Source Termination Resistor. (Note 2) |
| 14 | Q0 | CML Output | Inverted Differential Output 0 with Internal 50 Ω Source Termination Resistor. (Note 2) |
| 15 | Q0 | CML Output | Non-inverted Differential Output 0 with Internal 50 Ω Source Termination Resistor. (Note 2) |
| _ | EP | - | Exposed Pad. Thermal pad on the package bottom must be attached to a heatsinking conduit to improve heat transfer. It is recommended to connect the EP to the lower potential (V _{EE}). |

In the differential configuration when the input termination pins (V_{TCLK}, V_{TCLK}) are connected to a common termination voltage or left open, and if no signal is applied on CLK and CLK, then the device will be susceptible to self-oscillation.
 CML outputs require 50 Ω receiver termination resistors to V_{CC} for proper operation.

Table 2. ATTRIBUTES

| Characte | Value | | | | | |
|--|---|-------------------------------|---------|--|--|--|
| ESD Protection | Human Body Model Machine Model Charged Device Model | > 1500 V > 50 V > 500 V | | | | |
| Moisture Sensitivity (Note 3) | Pb Pkg | Pb-Free Pkg | | | | |
| | QFN-16 | Level 1 | Level 1 | | | |
| Flammability Rating | UL 94 V-0 @ 0.125 in | | | | | |
| Transistor Count | 38 | 37 | | | | |
| Meets or exceeds JEDEC Spec EIA/JESD78 IC Latchup Test | | | | | | |

^{3.} For additional information, see Application Note AND8003/D.

Table 3. MAXIMUM RATINGS

| Symbol | Parameter | Condition 1 | Condition 2 | Rating | Units |
|-------------------|--|--|-----------------------------|---|--------------|
| V _{CC} | Positive Power Supply | V _{EE} = 0 V | | 3.6 | V |
| VI | Input Voltage | V _{EE} = 0 V | $V_{EE} \le V_I \le V_{CC}$ | 3.6 | V |
| V _{INPP} | Differential Input Voltage CLK - CLK | $\begin{array}{c} V_{CC} - V_{EE} \geq 2.8 \text{ V} \\ V_{CC} - V_{EE} < 2.8 \text{ V} \end{array}$ | | 2.8 V _{CC} – V _{EE} | V V |
| I _{IN} | Input Current Through R_T (50 Ω Resistor) | Static Surge | | 45 80 | mA mA |
| l _{out} | Output Current | Continuous Surge | | 25 50 | mA mA |
| T _A | Operating Temperature Range | QFN-16 | | -40 to +85 | °C |
| T _{stg} | Storage Temperature Range | | | -65 to +150 | °C |
| θ_{JA} | Thermal Resistance (Junction-to-Ambient) (Note 4) | 0 lfpm 500 lfpm | QFN-16 QFN-16 | 42 36 | °C/W °C/W |
| $\theta_{\sf JC}$ | Thermal Resistance (Junction-to-Case) | 2S2P (Note 4) | QFN-16 | 3 to 4 | °C/W |
| T _{sol} | Wave Solder Pb Pb-Free | | | 265 265 | °C |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

4. JEDEC standard multilayer board – 2S2P (2 signal, 2 power).

Table 4. DC CHARACTERISTICS, CLOCK Inputs, CML Outputs ($V_{CC} = 2.375 \text{ V}$ to 3.465 V, $V_{EE} = 0 \text{ V}$, $T_A = -40 ^{\circ}\text{C}$ to $+85 ^{\circ}\text{C}$) (Note 5)

| Symbol | Characteristic | Min | Тур | Max | Unit |
|------------------------|--|-----------------------|-----------------------|-----------------------|-------|
| I _{CC} | Power Supply Current (Inputs and Outputs Open) | | 140 | 190 | mA |
| V _{OH} | Output HIGH Voltage (Note 6) | V _{CC} - 60 | V _{CC} – 20 | V _{CC} | mV |
| V _{OL} | Output LOW Voltage (Note 6) | V _{CC} - 530 | V _{CC} – 420 | V _{CC} – 360 | mV |
| Differential | Input Driven Single-Ended (see Figures 10 & 12) (Note 8) | • | • | • | |
| V _{th} | Input Threshold Reference Voltage Range (Note 7) | 1125 | | V _{CC} – 75 | mV |
| V _{IH} | Single-ended Input HIGH Voltage (Note 8) | V _{th} + 75 | | V _{CC} | mV |
| V _{IL} | Single-ended Input LOW Voltage (Note 8) | V _{EE} | | V _{th} – 75 | mV |
| Differential | Inputs Driven Differentially (see Figures 11 & 13) (Note 8) | | | | • |
| V _{IHCLK} | Differential Input HIGH Voltage | 1200 | | V _{CC} | mV |
| V _{ILCLK} | Differential Input LOW Voltage | V _{EE} | | V _{CC} – 75 | mV |
| V _{CMR} | Input Common Mode Range (Differential Configuration) | 1163 | | V _{CC} – 38 | mV |
| V _{ID} | Differential Input Voltage (V _{IHCLK} - V _{ILCLK}) | 75 | | 2500 | mV |
| I _{IH} | Input HIGH Current CLK / CLK (V _{TCLK} /V _{TCLK} Open) | 0 | 25 | 100 | μΑ |
| I _{IL} | Input LOW Current CLK / CLK (V _{TCLK} /V _{TCLK} Open) | -10 | 0 | 10 | μΑ |
| R _{TIN} | Internal Input Termination Resistor | 45 | 50 | 55 | Ω |
| R _{TOUT} | Internal Output Termination Resistor | 45 | 50 | 55 | Ω |
| R _{Temp Coef} | Internal I/O Termination Resistor Temperature Coefficient | | 6.38 | | mΩ/°C |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

- 5. Input and output parameters vary 1:1 with $V_{\mbox{\footnotesize CC}}$.
- 6. CML outputs require 50 Ω receiver termination resistors to V_{CC} for proper operation.
- V_{th} is applied to the complementary input when operating in single-ended mode.
 V_{CMR} min varies 1:1 with V_{CC}.

Table 5. AC CHARACTERISTICS ($V_{CC} = 2.375 \text{ V}$ to 3.465 V, $V_{EE} = 0 \text{ V}$; Note 9)

| | | -40°C | | 25°C | | 85°C | | | | | |
|--|--|------------|---------------------------------|--------------------------------|------------|---------------------------------|--------------------------------|------------|---------------------------------|--------------------------------|------|
| Symbol | Characteristic | Min | Тур | Max | Min | Тур | Max | Min | Тур | Max | Unit |
| V _{OUTPP} | Output Voltage Amplitude (@V _{INPPmin}) $f_{in} \le 6$ GHz (See Figure 4) $f_{in} \le 8$ GHz | 280 125 | 400 300 | | 280 125 | 400 300 | | 280 125 | 400 300 | | mV |
| f _{data} | Maximum Operating Data Rate | 10 | 12 | | 10 | 12 | | 10 | 12 | | Gb/s |
| t _{PLH} , t _{PHL} | Propagation Delay to Output Differential | 70 | 110 | 150 | 70 | 110 | 150 | 70 | 110 | 150 | ps |
| tskew | Duty Cycle Skew (Note 10) Within-Device Skew Device-to-Device Skew (Note 11) | | 2.0 6.0 20 | 5.0 15 50 | | 2.0 6.0 20 | 5.0 15 50 | | 2.0 6.0 20 | 5.0 15 50 | ps |
| ^t JITTER | $\begin{array}{ll} \text{RMS Random Clock Jitter (Note 12)} & f_{\text{in}} = 6 \text{ GHz} \\ f_{\text{in}} = 8 \text{ GHz} \\ \text{Peak/Peak Data Dependent Jitter} & f_{\text{in}} = 2.488 \text{ Gb/s} \\ \text{(Note 13)} & f_{\text{data}} = 5 \text{ Gb/s} \\ f_{\text{data}} = 10 \text{ Gb/s} \end{array}$ | | 0.2 0.2 2.0 5.0 6.0 | 0.5 0.5 5.0 8.0 10 | | 0.2 0.2 2.0 5.0 6.0 | 0.5 0.5 5.0 8.0 10 | | 0.2 0.2 2.0 5.0 6.0 | 0.5 0.5 5.0 8.0 10 | ps |
| V _{INPP} | Input Voltage Swing/Sensitivity (Differential Configuration) (Note 14) | 75 | 400 | 2500 | 75 | 400 | 2500 | 75 | 400 | 2500 | mV |
| t _r t _f | Output Rise/Fall Times @ 1 GHz Q, Q (20% – 80%) | | 30 | 60 | | 30 | 60 | | 30 | 60 | ps |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

- 9. Measured by forcing V_{INPP} (TYP) from a 50% duty cycle clock source. All loading with an external R_L = 50 Ω to V_{CC} . Input edge rates 40 ps (20% 80%).
- 10. Duty cycle skew is measured between differential outputs using the deviations of the sum of Tpw- and Tpw+ @1 GHz.
- 11. Device to device skew is measured between outputs under identical transition @ 1 GHz.
- 12. Additive RMS jitter with 50% duty cycle clock signal at 10 GHz.
- 13. Additive peak-to-peak data dependent jitter with input NRZ data at PRBS 2²³-1.
- 14. V_{INPP} (MAX) cannot exceed V_{CC} V_{EE}. Input voltage swing is a single-ended measurement operating in differential mode.

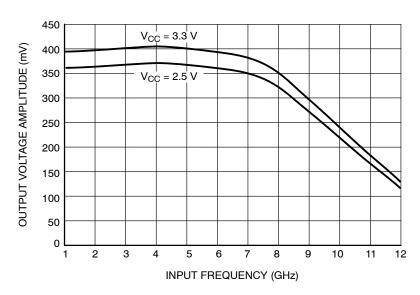


Figure 3. Output Voltage Amplitude (V_{OUTPP}) versus Input Clock Frequency (f_{in}) at Ambient Temperature (Typical) ($V_{INPP} = 400 \text{ mV}$)

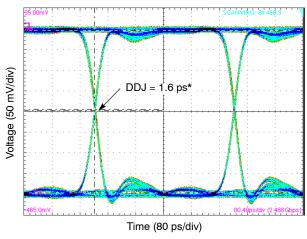


Figure 4. Typical Output Waveform at 2.488 Gb/s with PRBS 2²³-1 (V_{inpp} = 75 mV)

*Input signal DDJ = 6.4 ps

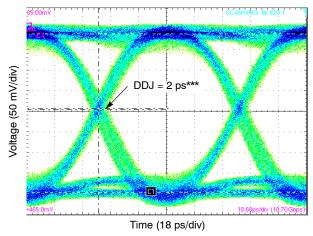


Figure 6. Typical Output Waveform at 10.7 Gb/s with PRBS 2^{23} -1 (V_{inpp} = 75 mV)

***Input signal DDJ = 11 ps

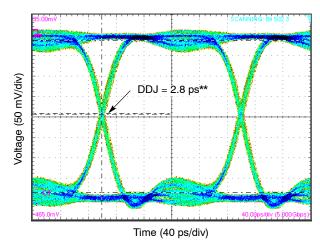


Figure 5. Typical Output Waveform at 5 Gb/s with PRBS 2²³-1 (V_{inpp} = 75 mV)

**Input signal DDJ = 7.2 ps

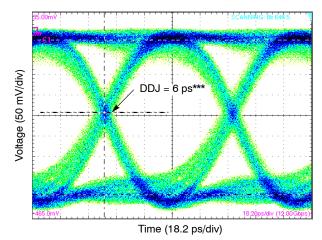


Figure 7. Typical Output Waveform at 12 Gb/s with PRBS 2²³-1 (V_{inpp} = 75 mV)

***Input signal DDJ = 13 ps

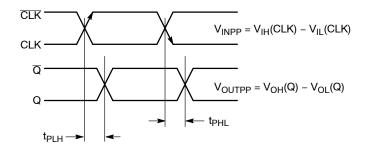


Figure 8. AC Reference Measurement

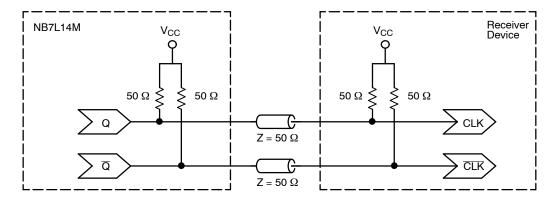


Figure 9. Typical Termination for 16 mA Output Driver and Device Evaluation (Refer to Application Notes AND8020/D and AND8173/D)

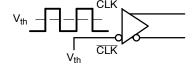


Figure 10. Differential Input Driven Single-Ended

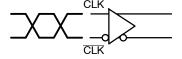


Figure 11. Differential Inputs Driven Differentially

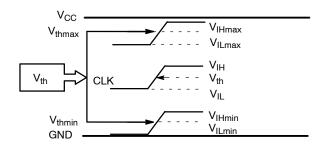


Figure 12. V_{th} Diagram

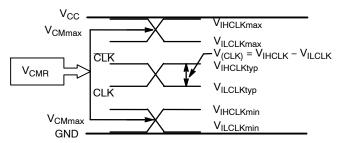


Figure 13. V_{CMR} Diagram

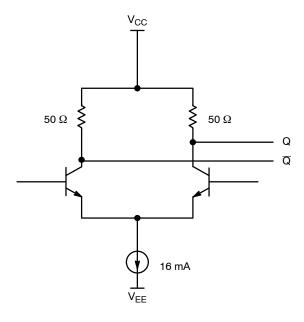


Figure 14. CML Output Structure

Table 6. INTERFACING OPTIONS

| INTERFACING OPTIONS | CONNECTIONS | | | |
|---------------------|--|--|--|--|
| CML | Connect V_{TCLK} and $\overline{V_{TCLK}}$ to V_{CC} | | | |
| LVDS | Connect V_{TCLK} , $\overline{V_{TCLK}}$ Together for CLK Input | | | |
| AC-COUPLED | Bias V_{TCLK} , $\overline{V_{TCLK}}$ Inputs within (VCMR) Common Mode Range | | | |
| RSECL, LVPECL | Standard ECL Termination Techniques. See AND8020/D. | | | |
| LVTTL, LVCMOS | An external voltage should be applied to the unused complementary differential input. Nominal voltage is 1.5 V for LVTTL and $V_{\rm CC}/2$ for LVCMOS inputs. | | | |

Application Information

All NB7L14M inputs can accept PECL, CML, LVTTL, LVCMOS and LVDS signal levels. The limitations for differential input signal (LVDS, PECL, or CML) are

minimum input swing of 75 mV and the maximum input swing of 2500 mV. Within these conditions, the input voltage can range from $V_{\rm CC}$ to 1.2 V. Examples interfaces are illustrated below in a 50 Ω environment (Z = 50 Ω).

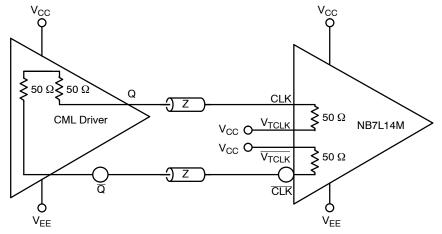


Figure 15. CML to CML Interface

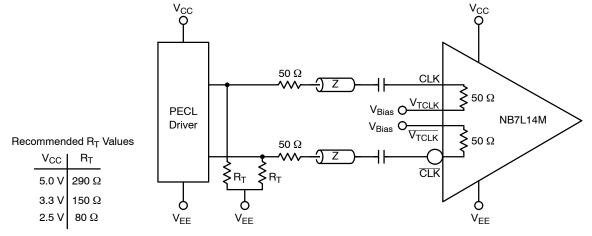


Figure 16. PECL to CML Receiver Interface

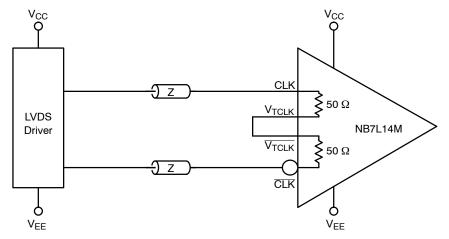


Figure 17. LVDS to CML Receiver Interface

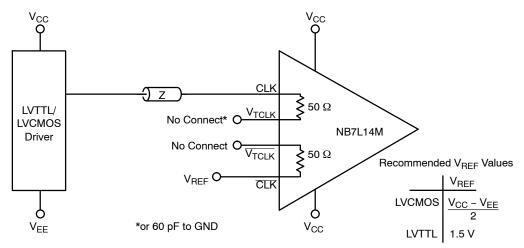


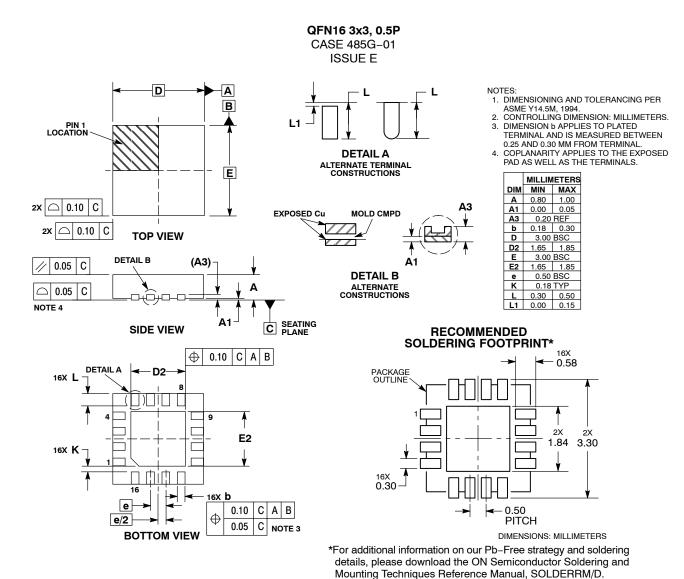
Figure 18. LVCMOS/LVTTL to CML Receiver Interface

ORDERING INFORMATION

| Device | Package | Shipping [†] | | |
|--------------|---------------------|-----------------------|--|--|
| NB7L14MMNG | QFN-16 (Pb-Free) | 123 Units/Rail | | |
| NB7L14MMNR2G | QFN-16 (Pb-Free) | 3000 / Tape & Reel | | |

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS



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